

# **STD15NF10**

## N-channel 100 V, 0.060 Ω, 23 A, DPAK low gate charge STripFET™ II Power MOSFET

#### **Features**

Туре	V <sub>DSSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STD15NF10	100 V	< 0.065 Ω	23 A

- Exceptional dv/dt capability
- 100% avalanche tested
- Application oriented characterization

### Application

Switching applications

#### Description

This MOSFET series realized with STMicroelectronics unique STripFET process has specifically been designed to minimize input capacitance and gate charge. It is therefore suitable as primary switch in advanced highefficiency, high-frequency isolated DC-DC converters for telecom and computer applications. It is also intended for any applications with low gate drive requirements.

Table 1. Device sum	mary		
Order code	Marking	Package	Packaging
STD15NF10T4	D15NF10	DPAK	Tape and reel



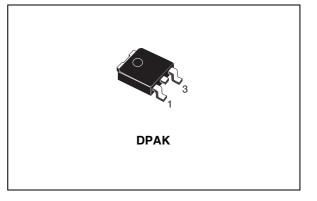
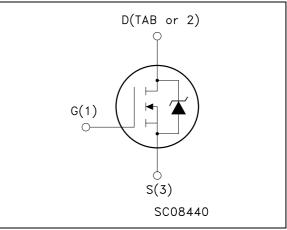


Figure 1. Internal schematic diagram



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#### 1

# Electrical ratings

Table 2.	Absolute	maximum	ratings
	Absolute	maximum	raungs

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage ( $V_{GS} = 0$ )	100	V
V <sub>DGR</sub>	Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )	100	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
Ι <sub>D</sub>	Drain current (continuous) at $T_C = 25 \ ^{\circ}C$	23	A
Ι <sub>D</sub>	Drain current (continuous) at $T_C$ =100 °C	16	A
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	92	A
P <sub>TOT</sub>	Total dissipation at $T_C = 25 \ ^{\circ}C$	70	W
	Derating factor	0.46	W/°C
E <sub>AS</sub> <sup>(2)</sup>	Single pulse avalanche energy	180	mJ
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	9	V/ns
T <sub>stg</sub>	Storage temperature	-55 to 175	°C
Т <sub>Ј</sub>	Max. operating junction temperature	-0010170	

1. Pulse width limited by safe operating area

2. Starting  $T_J$  = 25 °C,  $I_D$  = 10A,  $V_{DD}$  = 30V

3. I\_{SD}  $\ \leq \$  13 A, di/dt  $\ \leq \$  300 A/µs, V\_{DS}  $\ \leq \ V_{(BR)DSS}, \ T_{J} \ \leq \ T_{JMAX}$ 

	Table 3.	Thermal	data
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Symbol	Parameter	Value	Unit
R <sub>thJC</sub>	Thermal resistance junction-case max	2.14	°C/W
R <sub>thJA</sub>	Thermal resistance junction-ambient max	100	°C/W
TI	Maximum lead temperature for soldering purpose	300	°C



# 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0$	100			V
I <sub>DSS</sub>	Zero gate voltage drain current ( $V_{GS} = 0$ )	V <sub>DS</sub> = Max rating V <sub>DS</sub> = Max rating,@ 125 °C			1 10	μA μA
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS}$ = $V_{GS}$ , $I_D$ = 250 $\mu$ A	2	3	4	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 12 A		0.06	0.065	Ω

 Table 4.
 On<sup>(1)</sup> /off states

1. Pulsed: Pulse duration =  $300 \ \mu$ s, duty cycle 1.5%

#### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	$V_{DS} = 15 V_{,} I_{D} = 7.5 A$		12		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> = 25 V, f = 1 MHz, V <sub>GS</sub> = 0		870 125 50		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	V <sub>DD</sub> = 80 V, I <sub>D</sub> = 24 A V <sub>GS</sub> = 10 V		30 6 10	40	nC nC nC

1. Pulsed: pulse duration=300µs, duty cycle 1.5%

Table 6. Switching time
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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 50 \text{ V}, I_D = 12 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ Figure 13 on page 8		60 45 49 17		ns ns ns ns



Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current				23	А
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)				92	А
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 20 \text{ A}, V_{GS} = 0$			1.5	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>SD</sub> = 24 A, di/dt = 100 A/μs, V <sub>DD</sub> = 30 V, T <sub>J</sub> = 150 °C <i>Figure 15 on page 8</i>		100 375 7.5		ns nC A

 Table 7.
 Source drain diode

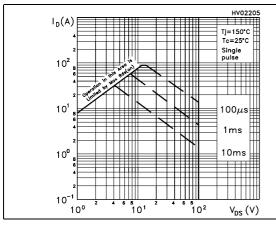
1. Pulse width limited by safe operating area.

2. Pulsed: pulse duration = 300  $\mu$ s, duty cycle 1.5%



#### 2.1 Electrical characteristics (curves)

#### Figure 2. Safe operating area





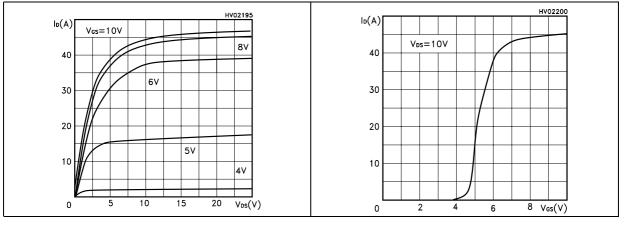


Figure 3.

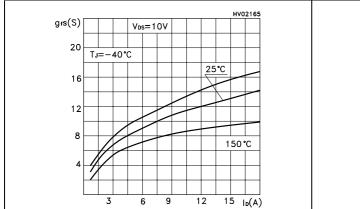
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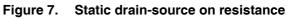
10 <sup>-1</sup>

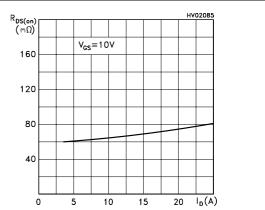
δ = 0.5

٥.









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SINGLE PULSE

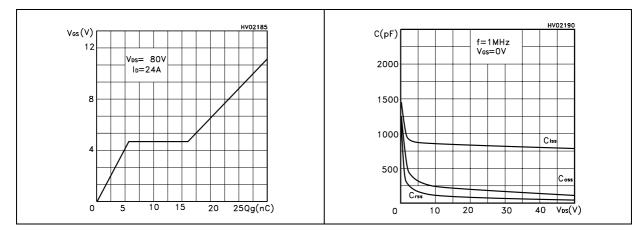
**Thermal impedance** 

0.05 0.02 0.01

 $Z_{th} = k R_{thJ-c}$ 

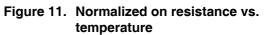
 $\delta=\,{\rm t_p}/\tau$ 

Figure 5. Transfer characteristics



#### Figure 8. Gate charge vs. gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage vs. temperature



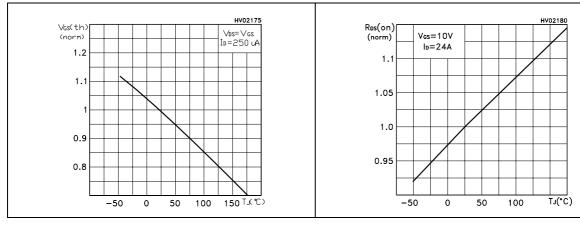
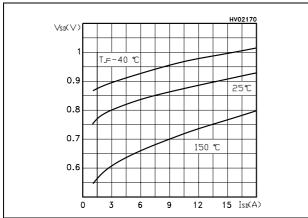


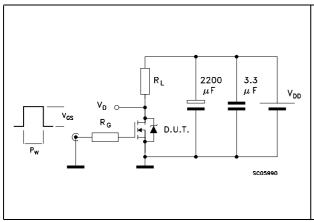
Figure 12. Source-drain diode forward characteristics





## 3 Test circuit

Figure 13. Switching times test circuit for resistive load



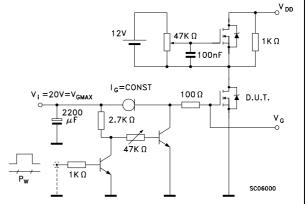
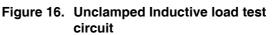
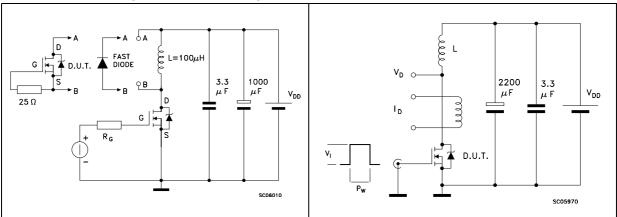


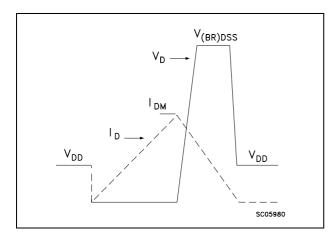
Figure 14. Gate charge test circuit

Figure 15. Test circuit for inductive load switching and diode recovery times









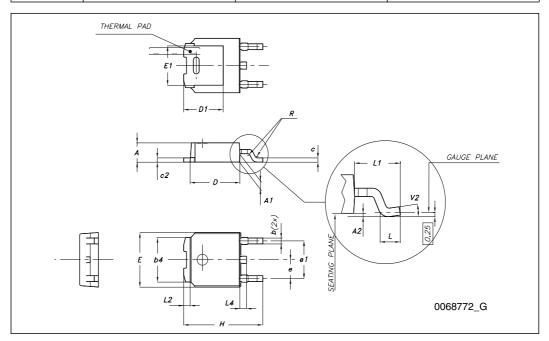
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



DIM	mm.			
	min.	typ	max.	
A	2.20		2.40	
A1	0.90		1.10	
42	0.03		0.23	
b	0.64		0.90	
o4	5.20		5.40	
с	0.45		0.60	
c2	0.48		0.60	
D	6.00		6.20	
D1		5.10		
E	6.40		6.60	
E1		4.70		
е		2.28		
e1	4.40		4.60	
н	9.35		10.10	
L	1			
_1		2.80		
2		0.80		
_4	0.60		1	
R		0.20		
V2	0 °		8 °	

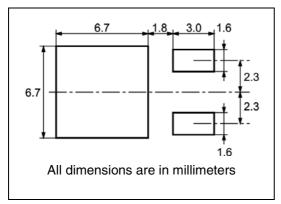




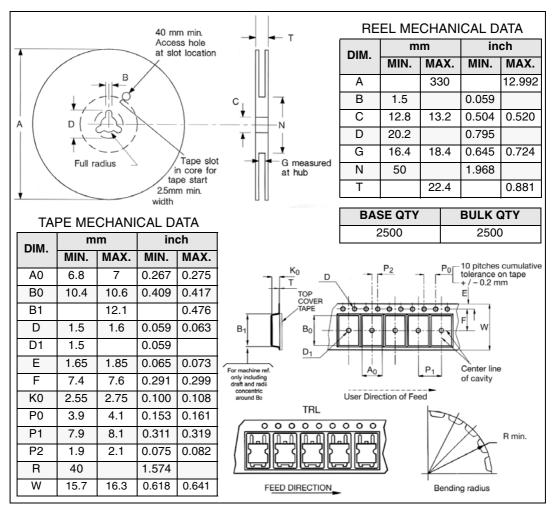
#### 5

# Packaging mechanical data

**DPAK FOOTPRINT** 



#### TAPE AND REEL SHIPMENT



# 6 Revision history

Table 8.	Revision	history
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Date	Revision	Changes
21-Jun-2004	3	No history because migration.
09-Sep-2004	4	Complete document
08-Aug-2006	5	New template, updated SOA
04-Nov-2008	6	Q <sub>G</sub> max value in <i>Table 5</i> has been corrected.



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